

Notice of References Cited	Application/Control No. 10/736,392	Applicant(s)/Patent Under Reexamination SHUKLA ET AL.	
	Examiner Shean C. Wu	Art Unit 1756	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,495,067	12-2002	Ono, Michio	252/299.61
	B	US-2004/0169158	09-2004	Kato et al.	252/299.2
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002-358821	12-2002	Japan	---	---
	O	EP 1033731	09-2000	EP		
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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